

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10783768	HARPER ET AL.
	Examiner Bautista, X. L	Art Unit 2179

SEARCHED

Class	Subclass	Date	Examiner
715	700,744,764,765,788,853	11/11/07	XB
715	500,503,504,505,508,517,520,523,530		

SEARCH NOTES

Search Notes	Date	Examiner
EAST Search	11/11/07	XB
Databases Searched:US-PGPUB; USPAT		
EPO; JPO; DERWENT; IBM_TDB		
Dialog Search		
Google Search		

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner